

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE  
(Case No. 02-1002-A)

In the Application of: )  
 )  
Jiang et al. )  
 )  
Serial No. To Be Assigned )  
 )  
Filed: Concurrently Herewith )  
 )  
Title: Reflective Optic System for Imaging )  
Microplate Readers )

**INFORMATION DISCLOSURE STATEMENT**

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Dear Sir:

Pursuant to 37 C.F.R. Section 1.97-1.98, applicants wish to make the following references of record in the above-identified application. These references may be material to the Examiner's consideration of the presently pending claims. Copies of the references cited below are enclosed along with a completed Form-1449.

**U.S. Patents**

	<u>Patent No.</u>	<u>Inventors</u>	<u>Issue Date</u>
1.	5,355,215	Schroeder et al.	October 11, 1994
2.	5,757,552	Murayama et al.	May 26, 1998
3.	6,128,139	Fukutake	October 3, 2000

	<u>Patent No.</u>	<u>Inventors</u>	<u>Issue Date</u>
4.	6,309,601	Juncosa et al.	October 30, 2001
5.	6,316,774	Giebeler et al.	November 21, 2001
6.	6,372,485	Clark et al.	April 16, 2002
7.	6,392,814	Ono	May 21, 2002
8.	6,469,311	Modlin et al.	October 22, 2002

### **Printed Publications**

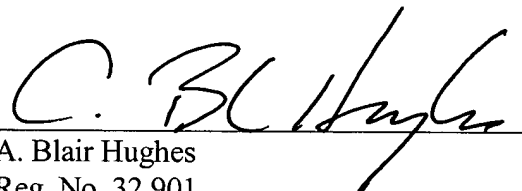
1. Shealy, et al. "Design and analysis of aspherical multilayer imaging x-ray microscope", *Optical Engineering*, Vol. 30, pp. 1094-1099 (1991).
2. Product Brochure, Reflecting Microscope Objectives, (September 2001).

Respectfully submitted,

**McDonnell Boehnen Hulbert & Berghoff**

Dated: December 17, 2003

By:

  
A. Blair Hughes  
Reg. No. 32,901

**FORM PTO-1449**  
(Rev. 2-32)

**U.S. Department of Commerce**  
**Patent and Trademark Office**

**Atty. Docket No.**

02-1002-A

**Serial No.**

To Be Assigned

**INFORMATION DISCLOSURE  
STATEMENT BY APPLICANT**

(Use several sheets if necessary)

**Applicant:**

Jiang et al.

**Filing Date:**  
Concurrently  
Herewith

**Group:**

**U.S. PATENT DOCUMENTS**

Examiner Initial	Document Number	Date	Name	Classes	Subclass	Filing Date if Appropriate
	5,355,215	10/11/94	Schroeder et al.			
	5,757,552	5/26/98	Murayama et al.			
	6,128,139	10/3/00	Fukutake			
	6,309,601	10/30/01	Juncosa et al.			
	6,316,774	11/21/01	Giebeler et al.			
	6,372,485	4/16/02	Clark et al.			
	6,392,814	5/21/02	Ono			
	6,469,311	10/22/02	Modlin et al.			

**FOREIGN PATENT DOCUMENTS**

Document Number	Date	Country	Class	Subclass	Translation
					Yes No

**OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc).**

Shealy, et al., "Design and analysis of aspherical multilayer imaging x-ray microscopic", *Optical Engineering*, Vol. 30, pp. 1094-1909 (1991).

Product Brochure, Reflecting Microscope Objectives (September 2001).

EXAMINER

DATE CONSIDERED

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication.